

### Issue Classification

Application/Control No.	Applicant(s)/Patent under Reexamination	
09/611,269	HASHIMOTO, SEIJI	
Examiner	Art Unit	
Nhan T. Tran	2615	

## ISSUE CLASSIFICATION

ORIGINAL					CROSS REFERENCE(S)								
CLASS		SUBCLASS			CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)							
348		241			348	222.1							
INTERNATIONAL CLASSIFICATION					358	443							
H	0	4	N	5/217	250	208.1							
H	0	4	N	5/228									
H	0	4	N	1/40									
H	0	1	L	27/00									
				/									

<i>Niamson</i> 6/23/05 (Assistant Examiner) (Date)		<i>Callahan</i> 6/27/05 DAVID L. OMETZ PRIMARY EXAMINER (Primary Examiner) (Date)		Total Claims Allowed: 1	
<i>Sturph</i> 6-27-05 (Legal Instruments Examiner) (Date)				O.G. Print Claim(s) 1	O.G. Print Fig. Fig. 5

[illegible]